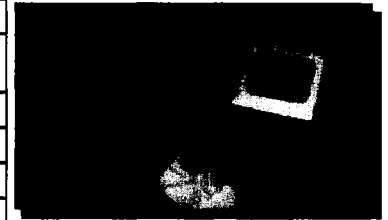


#### ● FEATURES

- ULTRA SMALL PACKAGE
- STABILITY TO  $\pm 0.25$  PPM
- CMOS OUTPUT

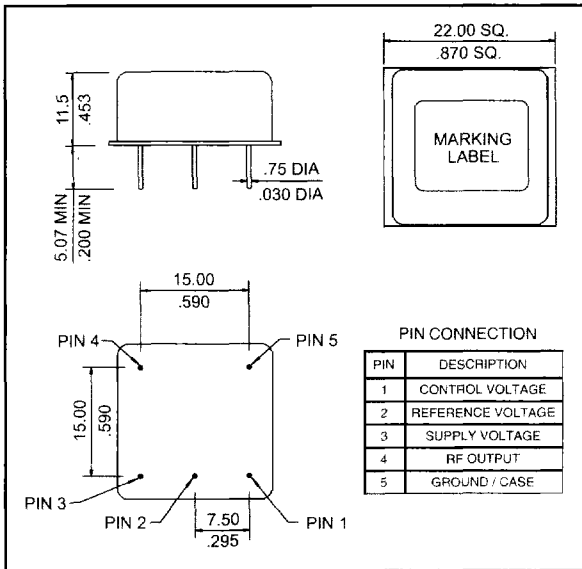
#### ● SPECIFICATIONS

FREQUENCY RANGE	10.00 to 50.00 MHz
FREQUENCY STABILITY VS. OPERATING TEMPERATURE	$\pm 0.1$ PPM OVER $0^{\circ}\text{C}$ TO $+60^{\circ}\text{C}$ $\pm 0.25$ PPM OVER $-20^{\circ}\text{C}$ TO $+70^{\circ}\text{C}$ (OTHER STABILITIES AVAILABLE)
FREQUENCY STABILITY VS. AGING	$\pm 0.3$ PPM FIRST YEAR AND $\pm 2.0$ PPM OVER 10 YEARS STANDARD
OUTPUT	CMOS AT NOMINAL LOAD OF 10 K OHM // 15 pF
OUTPUT LEVEL	$\text{VOH} = 4.2 \text{ V MIN}$ AND $\text{VOL} = 0.4 \text{ V MAX}$
DUTY CYCLE	40/60 %
RISE AND FALL TIME	10 ns MAX AT NOMINAL LOAD
FREQUENCY STABILITY VS. LOAD VARIATION	$\pm 0.005$ PPM FOR $\pm 10\%$ VARIATION
SUPPLY VOLTAGE	+5.0 VDC $\pm 5\%$
FREQUENCY STABILITY VS. SUPPLY VARIATION	$\pm 0.01$ PPM FOR $\pm 5\%$ VARIATION
SUPPLY CURRENT	WARM-UP: 400 mA TYP AND 500 mA MAX AT $+25^{\circ}\text{C}$
	STEADY STATE: 110 mA TYP AND 150 mA MAX AT $+25^{\circ}\text{C}$
WARMUP TIME	2.0 min TYP AND 3.0 min MAX AT $+25^{\circ}\text{C}$
ADJUSTMENT TOLERANCE	$\pm 1.0$ PPM AT $\text{VC} = +2.5 \text{ V}$
FREQUENCY PULLING RANGE	$\pm 3.0$ PPM MINIMUM AT $\text{VC} = +2.5 \text{ V} \pm 2.0 \text{ V}$
TYPICAL PHASE NOISE	SEE PHASE NOISE CHARACTERISTICS GRAPH
STORAGE TEMPERATURE RANGE	$-40^{\circ}\text{C}$ TO $+85^{\circ}\text{C}$

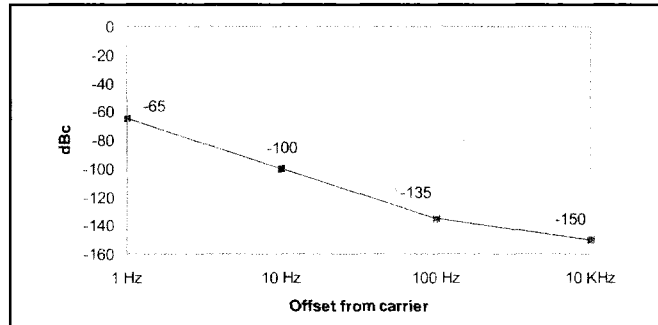


#### ● OUTLINE DRAWING

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#### ● PHASE NOISE CHARACTERISTICS



#### ● PART NUMBERING SYSTEM

TYPE	OUTPUT TYPE	CRYSTAL CUT	PACKAGE TYPE	REVISION LEVEL	TEMPERATURE RANGE	FREQUENCY STABILITY	FREQUENCY
OX	9: CMOS	1: AT CUT	51	RALTRON ASSIGNED	LX: $0^{\circ}\text{C}$ TO $+60^{\circ}\text{C}$ HZ: $-20^{\circ}\text{C}$ TO $+70^{\circ}\text{C}$	10: 0.1 PPM 25: 0.25 PPM	IN MHZ

EXAMPLE: OX9151A-HZ-25-10.000